

**Search Notes**

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Examiner

Alex Liew

Applicant(s)/Patent under  
Reexamination

LUK ET AL.

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
382/181-231,284 limited to text search	12/1/2007	AL
382/155-161 limited to text search	12/4/2007	AL